

1. Record Nr.	UNINA9911019813103321
Titolo	Oxide ultrathin films : science and technology // edited by Gianfranco Pacchioni and Sergio Valeri
Pubbl/distr/stampa	Weinheim, Germany, : Wiley-VCH, c2012
ISBN	9783527640188 3527640185 9783527640195 3527640193 9783527640171 3527640177
Descrizione fisica	1 online resource (723 p.)
Classificazione	530 540 UP 7560
Altri autori (Persone)	PacchioniG <1954-> (Gianfranco) ValeriSergio
Disciplina	621.38152
Soggetti	Thin films Oxides
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Description based upon print version of record.
Nota di bibliografia	Includes bibliographical references and index.
Nota di contenuto	Cover; Contents; Title; Copyright; Preface; List of Contributors; Chapter 1: Synthesis and Preparation of Oxide Ultrathin Films; 1.1 Introduction; 1.2 Basic Aspects of Fabrication; 1.3 Physical Methods; 1.4 Chemical Methods; 1.5 Oxide Nanosheets and Buried Layers; 1.6 Conclusions and Perspectives; Chapter 2: Characterization Tools of Ultrathin Oxide Films; 2.1 Introduction; 2.2 Structure Determination Techniques; 2.3 Spectroscopic Techniques; 2.4 Summary; Chapter 3: Ordered Oxide Nanostructures on Metal Surfaces; 3.1 Introduction; 3.2 Fabrication of Oxide Nanostructures 3.3 Novel Structure Concepts3.4 Dimensionality Aspects: from Two- to One- to Zero-Dimensional Structures; 3.5 Transition from Two- to Three-Dimensional Structures: Growth of Bulk Structures out of Interfacial Layers; 3.6 Synopsis; Acknowledgment; Chapter 4: Unusual Properties of Oxides and Other Insulators in the Ultrathin Limit; 4.1

Introduction; 4.2 Evolution of Band Gap with Film Thickness; 4.3 Electronic Transport through Oxide Ultrathin Films; 4.4 Work Function Changes Induced by Oxide Films; 4.5 Nanoporosity: Oxide Films as Molecular and Atomic Sieves  
 4.6 Flexibility of Oxide Thin Films and Polaronic Distortion  
 4.7 Conclusions; Acknowledgments; Chapter 5: Silica and High-k Dielectric Thin Films in Microelectronics; 5.1 Introduction; 5.2 Electrical Characterization of High-k Dielectrics on Silicon; 5.3 Theoretical Modeling of Gate Dielectric Films; 5.4 Models of the Structure and Properties of HfO<sub>2</sub> Gate Dielectric Films; 5.5 Polycrystalline Gate Oxide Films; 5.6 Conclusions and Outlook; Acknowledgments; Chapter 6: Oxide Passive Films and Corrosion Protection; 6.1 Introduction; 6.2 Electrochemical Fundamentals of Passivation of Metals  
 6.3 Chemical Composition, Chemical States, and Thickness of Passive Films on Metals and Alloys  
 6.4 Two-Dimensional Oxide Passive Films on Metals; 6.5 Growth and Nanostructure of Three-Dimensional Ultrathin Oxide Films; 6.6 Corrosion Modeling by DFT; 6.7 Conclusion; Chapter 7: Oxide Films as Catalytic Materials and Models of Real Catalysts; 7.1 Introduction; 7.2 Oxide Thin Films Grown as Supports; 7.3 Systems to Model Real Catalysts; 7.4 Ultrathin-Film Catalysts; 7.5 Synopsis; Acknowledgments; Chapter 8: Oxide Films in Spintronics; 8.1 Introduction; 8.2 Historical Notes  
 8.3 Half-Metallic Manganites: the Case of LSMO  
 8.4 Electric Control of Magnetization in Oxide Heterostructures; 8.5 Conclusions and Perspectives; Acknowledgments; Chapter 9: Oxide Ultrathin Films for Solid Oxide Fuel Cells; 9.1 Overview of Solid Oxide Fuel Cell Technology; 9.2 Preparation of Oxide Ion Conductor Thin Films; 9.3 Nano Size Effects on Oxide Ion Conductor Films; 9.4 Power Generating Property of SOFCs using LaGaO<sub>3</sub> Thin Films; 9.5 Development of -SOFCs; 9.6 Concluding Remarks; Chapter 10: Transparent Conducting and Chromogenic Oxide Films as Solar Energy Materials; 10.1 Introduction  
 10.2 Transparent Infrared Reflectors and Transparent Electrical Conductors

## Sommario/riassunto

A wealth of information in one accessible book. Written by international experts from multidisciplinary fields, this in-depth exploration of oxide ultrathin films covers all aspects of these systems, starting with preparation and characterization, and going on to geometrical and electronic structure, as well as applications in current and future systems and devices. From the Contents: Synthesis and Preparation of Oxide Ultrathin Films  
 Characterization Tools of Oxide Ultrathin Films  
 Ordered Oxide Nanostructures on Metal Surfaces  
 Unusual Properties of